

A comparative study of fault diagnosis for train door system: traditional versus deep learning approaches

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Sensors (Basel)

2019; 19(23):s19235160

ARTICLE IDENTIFIERS

DOI: 10.3390/s19235160

PMID: 31775338

PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 2002242115

pISSN: not available

eISSN: 1424-8220

OCLC ID: 47250782

CONS ID: not available

US National Library of Medicine ID: 101204366

This article was identified from a query of the SafetyLit database.